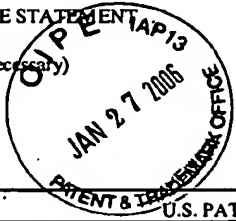


Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 100629.03		APPLICATION NO. 10/625,617	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Tokuroh OZAWA et al. FILING DATE July 24, 2003			



U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number	Date	Name
J.L	1	5,250,931	10-05-93	Toshiyuki MISAWA

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation

OTHER DOCUMENTS		
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER <i>Dean Lyman</i>	DATE CONSIDERED <i>3/31/2006</i>
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Date: January 27, 2006

Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 100629.03		APPLICATION NO. 10/625,617	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Tokuroh OZAWA et al.			
				FILING DATE July 24, 2003		GROUP 2674	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
J.L.	1	JP 04-106530	04/08/1992	Japan	X		
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER		<i>Pau Negreanu</i>				DATE CONSIDERED <i>3/31/06</i>	
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Date: March 10, 2006